July 2008

UniFET

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FDB52N20 200V N-Channel MOSFET

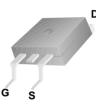
Features

- 52A, 200V, $R_{DS(on)} = 0.049\Omega @V_{GS} = 10 V$
- Low gate charge (typical 49 nC)
- Low C_{rss} (typical 66 pF)
- · Fast switching
- 100% avalanche tested
- Improved dv/dt capability

Description

These N-Channel enhancement mode power field effect transistors are produced using Fairchild's proprietary, planar stripe, DMOS technology.

This advanced technology has been especially tailored to minimize on-state resistance, provide superior switching performance, and withstand high energy pulse in the avalanche and commutation mode. These devices are well suited for high efficient switched mode power supplies and active power factor correction.



G O S

Absolute Maximum Ratings

| Symbol | Parameter | | | FDB52N20 | Unit | |
|----------------------------------|--|--|----------|-------------|-----------|--|
| V _{DSS} | Drain-Source Voltage | | | 200 | V | |
| I _D | Drain Current | - Continuous (T _C = 25° - Continuous (T _C = 100 | | 52 33 | A A | |
| I _{DM} | Drain Current | - Pulsed | (Note 1) | 208 | A | |
| V _{GSS} | Gate-Source voltage | | | ±30 | V | |
| E _{AS} | Single Pulsed Avalanche Energy | | (Note 2) | 2520 | mJ | |
| I _{AR} | Avalanche Current | | (Note 1) | 52 | A | |
| E _{AR} | Repetitive Avalance | he Energy | (Note 1) | 35.7 | mJ | |
| dv/dt | Peak Diode Recov | ery dv/dt | (Note 3) | 4.5 | V/ns | |
| P _D | Power Dissipation $(T_C = 25^{\circ}C)$ - Derate above $25^{\circ}C$ | | | 357 2.86 | W W/°C | |
| T _{J,} T _{STG} | Operating and Storage Temperature Range | | | -55 to +150 | °C | |
| Τ _L | Maximum Lead Temperature for Soldering Purpose, 1/8" from Case for 5 Seconds | | rpose, | 300 | °C | |

Thermal Characteristics

| Symbol | Parameter | Min. | Max. | Unit |
|-----------------------|--|------|------|------|
| $R_{	extsf{	heta}JC}$ | Thermal Resistance, Junction-to-Case | | 0.35 | °C/W |
| R _{θJA} * | Thermal Resistance, Junction-to-Ambient* | | 40 | °C/W |
| $R_{	extsf{	heta}JA}$ | R _{0JA} Thermal Resistance, Junction-to-Ambient | | 62.5 | °C/W |

* When mounted on the minimum pad size recommended (PCB Mount)

Package Marking and Ordering Information

| Device Marking | Device | Package | Reel Size | Tape Width | Quantity |
|----------------|------------|---------------------|-----------|------------|----------|
| FDB52N20 | FDB52N20TM | D ² -PAK | 330mm | 24mm | 800 |

Electrical Characteristics T_c = 25°C unless otherwise noted

| Symbol | Parameter | Conditions | Min. | Тур. | Max | Units |
|---|---|--|------|-------|---------|----------|
| Off Charac | teristics | | | | L | |
| BV _{DSS} | Drain-Source Breakdown Voltage | $V_{GS} = 0V, I_{D} = 250 \mu A$ | 200 | | | V |
| ΔBV _{DSS} / ΔT _J | Breakdown Voltage Temperature Coefficient $I_D = 250 \mu A$, Referenced to $25^{\circ}C$ | | | 0.2 | | V/°C |
| I _{DSS} | Zero Gate Voltage Drain Current $V_{DS} = 200V, V_{GS} = 0V$ $V_{DS} = 160V, T_C = 125^{\circ}C$ | | | | 1 10 | μΑ μΑ |
| I _{GSSF} | Gate-Body Leakage Current, Forward | $V_{GS} = 30V, V_{DS} = 0V$ | | | 100 | nA |
| I _{GSSR} | Gate-Body Leakage Current, Reverse | $V_{GS} = -30V, V_{DS} = 0V$ | | | -100 | nA |
| On Charac | teristics | | | | | |
| V _{GS(th)} | Gate Threshold Voltage | $V_{DS} = V_{GS}, I_D = 250 \mu A$ | 3.0 | | 5.0 | V |
| R _{DS(on)} | Static Drain-Source On-Resistance | V _{GS} = 10V, I _D = 26A | | 0.041 | 0.049 | Ω |
| 9 _{FS} | Forward Transconductance | $V_{DS} = 40V, I_D = 26A$ (Note 4) | | 35 | | S |
| Dynamic C | haracteristics | | | | | • |
| C _{iss} | Input Capacitance | $V_{DS} = 25V, V_{GS} = 0V,$ | | 2230 | 2900 | pF |
| C _{oss} | Output Capacitance | f = 1.0MHz | | 540 | 700 | pF |
| C _{rss} | Reverse Transfer Capacitance | | | 66 | 100 | pF |
| Switching | Characteristics | | | | | |
| t _{d(on)} | Turn-On Delay Time | V _{DD} = 100V, I _D = 52A | | 53 | 115 | ns |
| t _r | Turn-On Rise Time | $R_{G} = 25\Omega$ | | 175 | 359 | ns |
| t _{d(off)} | Turn-Off Delay Time | | | 48 | 107 | ns |
| t _f | Turn-Off Fall Time | (Note 4, 5) | | 29 | 68 | ns |
| Qg | Total Gate Charge | V _{DS} = 160V, I _D = 52A | | 49 | 63 | nC |
| Q _{gs} | Gate-Source Charge | V _{GS} = 10V | | 19 | | nC |
| Q _{gd} | Gate-Drain Charge | (Note 4, 5) | | 24 | | nC |
| - | rce Diode Characteristics and Maximur | n Ratings | | | | • |
| I _S | Maximum Continuous Drain-Source Diode Forward Current | | | | 52 | A |
| I _{SM} | Maximum Pulsed Drain-Source Diode Forward Current | | | | 204 | Α |
| V _{SD} | Drain-Source Diode Forward Voltage | V _{GS} = 0V, I _S = 52A | | | 1.4 | V |
| t _{rr} | Reverse Recovery Time | V _{GS} = 0V, I _S = 52A | | 162 | | ns |
| Q _{rr} | Reverse Recovery Charge | dI _F /dt =100A/μs (Note 4) | | 1.3 | | μC |

NOTES:

1. Repetitive Rating: Pulse width limited by maximum junction temperature

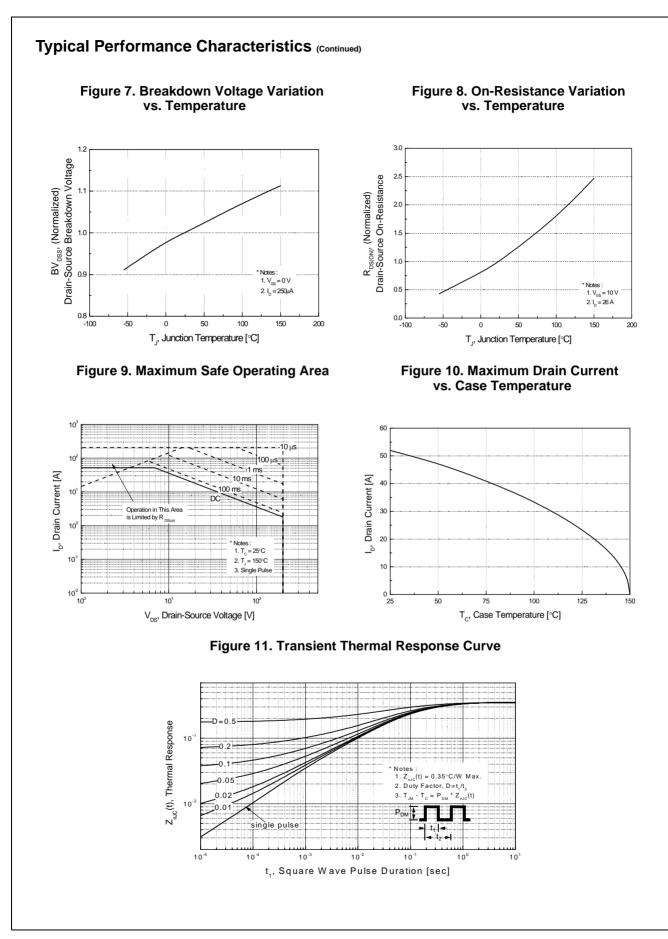
2. L = 1.4mH, I_{AS} = 52A, V_{DD} = 50V, R_G = 25 Ω , Starting T_J = 25°C

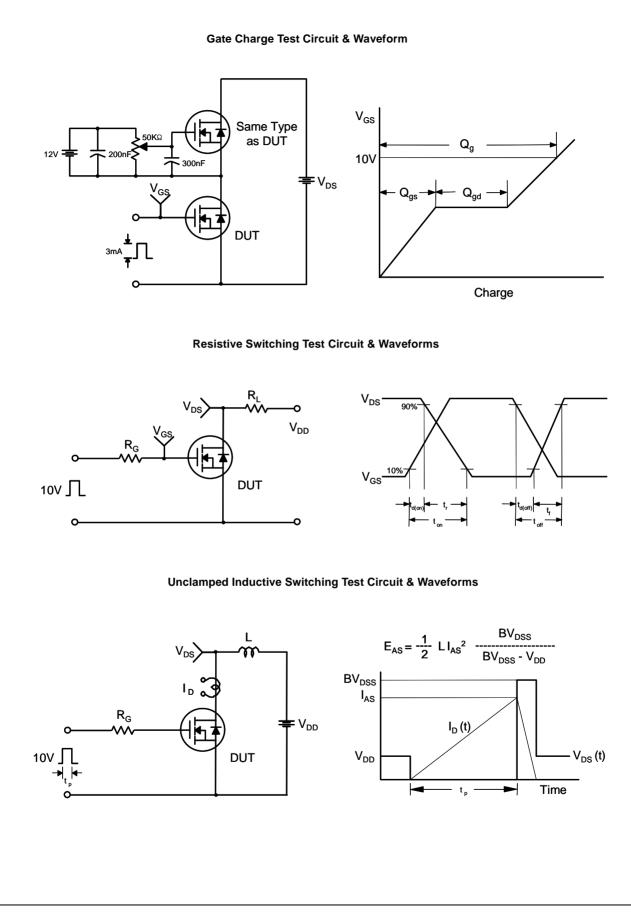
3. I_{SD} \leq 52A, di/dt \leq 200A/\mu s, V_{DD} \leq BV_{DSS}, Starting T_J = 25^{\circ}C

4. Pulse Test: Pulse width \leq 300µs, Duty Cycle \leq 2%

5. Essentially Independent of Operating Temperature Typical Characteristics

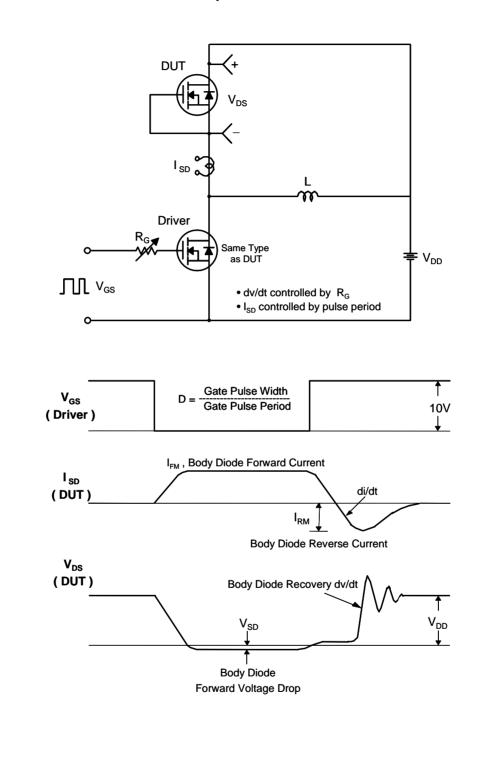
Typical Performance Characteristics Figure 1. On-Region Characteristics Figure 2. Transfer Characteristics V_{gs} 15.0 V 10.0 V Тор 10² 10 8.0 V 7.0 V 6.5 V 6.0 V I_D, Drain Current [A] I_b, Drain Current [A] 5.5 10 150°C 10 -55°C 10 Notes 1. V_{DS} = 40V 2. 250µs Pulse Test 1. 250µs Pulse Tes 2. T_c = 25°C 10 10[°] 10-1 100 10¹ 10 2 12 V_{DS}, Drain-Source Voltage [V] V_{GS}, Gate-Source Voltage [V] Figure 3. On-Resistance Variation vs. Figure 4. Body Diode Forward Voltage Drain Current and Gate Voltage Variation vs. Source Current and Temperatue 0.12 10 0.10 R_{DS(ON)} [Ω], Drain-Source On-Resistance Reverse Drain Current [A] 0.08 = 10V٧... 0.06 10 150°C 0.04 $V_{gs} = 20V$ 0.02 Notes : Ę, 1. V_{GS} = 0V 2. 250μs Pulse Test * Note : T, = 25°C 10⁰ ⊾ 0.2 0.00 ັດ 25 50 75 100 125 150 1.6 0.4 0.6 0.8 1.0 1.2 1.4 1.8 I_D, Drain Current [A] V_{sp}, Source-Drain voltage [V] **Figure 5. Capacitance Characteristics Figure 6. Gate Charge Characteristics** 12 6000 + C. $V_{DS} = 40V$ 10 5000 Gate-Source Voltage [V] V_{DS} = 100V V_{DS} = 160 8 4000 Capacitances [pF] 6 3000 2000 Note ; 1. V_{GS} = 0 V 2. f = 1 MHz $^{\sf SS'}$ 1000 2 * Note : I_D = 52A 0 0 10 10 10 20 30 40 50 60 V_{ps}, Drain-Source Voltage [V] Q_G, Total Gate Charge [nC]



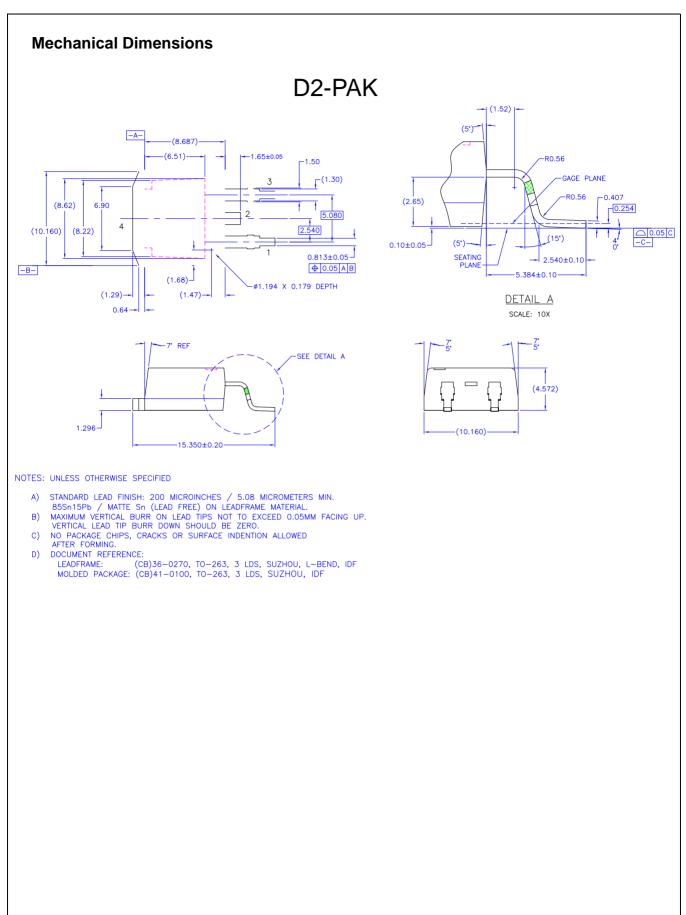


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Peak Diode Recovery dv/dt Test Circuit & Waveforms









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